

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	52,55,57, 63,65,89	6/20/2005	HLN
—	560-563		
330	252,253		
✓	269		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Search	Above	6/20/2005	HLN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	6/20/2005	HLN